

In the case of p-type semiconductor

From the charge neutrality condition, the hole concentration in the freeze-out range is expressed as

$$N_v(T) \exp\left(-\frac{\Delta E_F}{kT}\right) = N_A \frac{1}{1 + 4 \exp\left(\frac{\Delta E_A - \Delta E_F}{kT}\right)} \quad (1)$$

When we define x as

$$x = \exp\left(-\frac{\Delta E_F}{kT}\right), \quad (2)$$

Eq. (1) can be rewritten as a quadratic equation:

$$ax^2 + bx + c = 0, \quad (3)$$

where

$$a = 4N_v(T) \exp\left(\frac{\Delta E_A}{kT}\right), \quad (4)$$

$$b = N_v(T), \quad (5)$$

and

$$c = -N_A. \quad (6)$$

The solution of Eq. (3) is

$$x = \frac{-b \pm \sqrt{b^2 - 4ac}}{2a} \quad (7)$$

or

$$x = \left(-\frac{b}{2a}\right) \pm \sqrt{\left(\frac{b}{2a}\right)^2 - \left(\frac{c}{a}\right)}. \quad (8)$$

When

$$\left(\frac{b}{2a}\right)^2 \ll \left(\frac{c}{a}\right) \quad (9)$$

that is

$$N_A \gg \frac{N_v(T)}{16} \exp\left(-\frac{\Delta E_A}{kT}\right) \quad (10)$$

the solution is

$$x = \sqrt{\frac{-c}{a}} \quad (11)$$

that is

$$\exp\left(-\frac{\Delta E_F}{kT}\right) = \frac{1}{2} \sqrt{\frac{N_A}{N_v(T)} \exp\left(-\frac{\Delta E_A}{kT}\right)}. \quad (12)$$

Therefore, $p(T)$ is derived as

$$p(T) = N_v(T) \exp\left(-\frac{\Delta E_F}{kT}\right) = \frac{1}{2} \sqrt{N_A N_v(T)} \exp\left(-\frac{\Delta E_A}{2kT}\right). \quad (13)$$

Since

$$N_v(T) = 2 \left(\frac{2\pi m^* kT}{h^2} \right)^{3/2}, \quad (14)$$

we obtain the following relationship:

$$p(T) = T^{3/4} \sqrt{\left(\frac{2\pi m^* k}{h^2} \right)^{3/2}} \sqrt{N_A} \exp\left(-\frac{\Delta E_A}{kT}\right). \quad (15)$$